

Notice of References Cited	Application/Control No. 10/519,766	Applicant(s)/Patent Under Reexamination SCHULTHEIS ET AL.	
	Examiner DAVID BANH	Art Unit 2854	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,096,443 A	08-2000	Malhotra et al.	428/690
*	C	US-2002/0088799 A1	07-2002	Behnke et al.	219/679
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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